

40V Complementary Enhancement Mode MOSFET

● **Features**

N-channel

V_{DS}	$R_{DS(ON)TYP}$	I_D
40V	25 mΩ@10V	6A
	40 mΩ@4.5V	

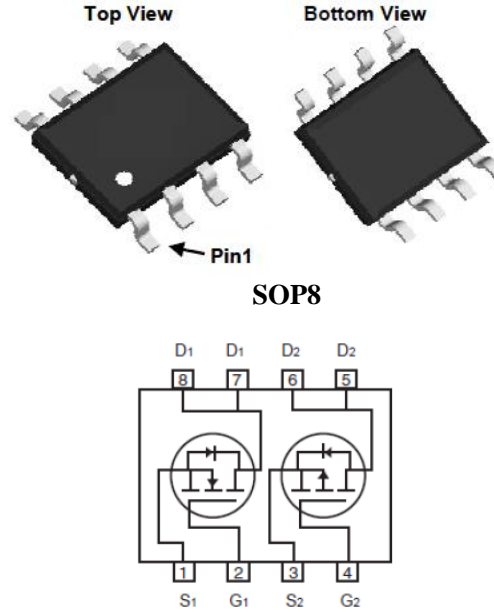
P-channel

V_{DS}	$R_{DS(ON)TYP}$	I_D
-40V	40 mΩ@-10V	-5.1A
	55 mΩ@-4.5V	

● **General Description**

- used in inverter
- other applications

● **Pin Configurations**



● **Absolute Maximum Ratings @ $T_A=25^{\circ}C$ unless otherwise noted**

Parameter	Symbol	N-Ratings	P-Ratings	Unit	
Drain-Source Voltage	V_{DSS}	40	-40	V	
Gate-Source Voltage	V_{GSS}	± 20	± 20	V	
Drain Current (Continuous) *AC	I_D	$T_A=25^{\circ}C$	6	-5.1	A
		$T_A=100^{\circ}C$	3.9	-3.2	
Drain Current (Pulse) *B	I_{DM}	24	-20	A	
Power Dissipation	P_D	2		W	
Operating Temperature/ Storage Temperature	T_J/T_{STG}	-55~150	-55~150	$^{\circ}C$	

● **Thermal Resistance Ratings**

Parameter	Symbol	Maximum	Unit
Maximum Junction-to-Ambient	R_{thJA}	62.5	$^{\circ}C/W$

Electrical Characteristics

N-Channel

$T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	40	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 40V, V_{GS} = 0V$	--	--	1	μA
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_{DS} = 250\mu A$	1	1.6	2.2	V
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	--	--	± 100	nA
Drain-Source On-state Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 6A$	--	25	35	m Ω
	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 5A$	--	40	55	m Ω
Diode Forward Voltage	V_{SD}	$I_{SD} = 1A, V_{GS} = 0V$	--	0.77	1.3	V
Diode Forward Current *AC	I_S	$T_A = 25^\circ\text{C}$	--	--	2.6	A
Switching						
Total Gate Charge	Q_g	$V_{GS} = 10V, V_{DS} = 20V,$ $I_{DS} = 6A$	--	11	--	nC
Gate-Source Charge	Q_{gs}		--	2	--	nC
Gate-Drain Charge	Q_{gd}		--	2.2	--	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = 20V, V_{GEN} = 10V,$ $R_G = 3.3\Omega, R_L = 3.3\Omega,$ $I_{DS} = 6A$	--	1.9	--	ns
Turn-on Rise Time	t_r		--	18.6	--	ns
Turn-off Delay Time	$t_{d(off)}$		--	8.7	--	ns
Turn-Off Fall Time	t_f		--	2.6	--	ns
Reverse Recovery Time	t_{rr}	$I_{SD} = 6A, dI_{SD}/dt = 100A/\mu s$		4		ns
Reverse Recovery Charge	Q_{rr}			1.5		nC
Dynamic						
Input Capacitance	C_{iss}	$V_{DS} = 20V, V_{GS} = 0V,$ $f = 1.0\text{ MHz}$	--	600	--	pF
Output Capacitance	C_{oss}		--	62	--	pF
Reverse Transfer Capacitance	C_{rss}		--	48	--	pF

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C: The current rating is based on the $t \leq 10s$ junction to ambient thermal resistance rating.

Electrical Characteristics

P-Channel

$T_A=25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250 \mu A$	-40	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -40V, V_{GS} = 0V$	--	--	-1	μA
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_{DS} = -250 \mu A$	-1	-1.6	-2.2	V
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$	--	--	± 100	nA
Drain-Source On-state Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -4A$	--	40	50	m Ω
	$R_{DS(on)}$	$V_{GS} = -4.5V, I_D = -3A$	--	55	75	m Ω
Diode Forward Voltage	V_{SD}	$I_{SD} = -1A, V_{GS} = 0V$	--	-0.78	-1.2	V
Diode Forward Current *AC	I_S	$T_A = 25^{\circ}\text{C}$	--	--	-2.6	A
Switching						
Total Gate Charge	Q_g	$V_{GS} = -10V, V_{DS} = -20V,$ $I_{DS} = -5.1A$	--	20	--	nC
Gate-Source Charge	Q_{gs}		--	5.7	--	nC
Gate-Drain Charge	Q_{gd}		--	4.6	--	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = -20V, V_{GEN} = -10V,$ $R_G = 3.3\Omega, R_L = 3.9\Omega,$ $I_{DS} = -5.1A$	--	6.8	--	ns
Turn-on Rise Time	t_r		--	33	--	ns
Turn-off Delay Time	$t_{d(off)}$		--	30	--	ns
Turn-Off Fall Time	t_f		--	12	--	ns
Reverse Recovery Time	t_{rr}	$I_{SD} = 6A, dI_{SD}/dt = 100A/\mu s$	--	6.1	--	ns
Reverse Recovery Charge	Q_{rr}		--	1.6	--	nC
Dynamic						
Input Capacitance	C_{iss}	$V_{DS} = -20V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	--	1100	--	pF
Output Capacitance	C_{oss}		--	100	--	pF
Reverse Transfer Capacitance	C_{rss}		--	80	--	pF

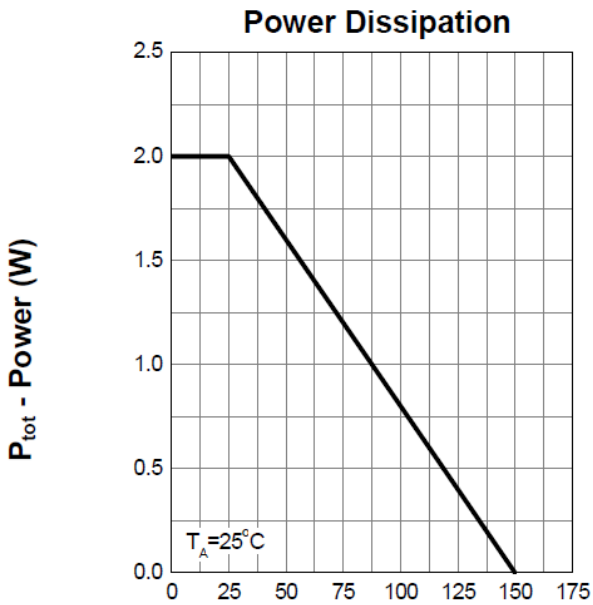
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B: Repetitive rating, pulse width limited by junction temperature.

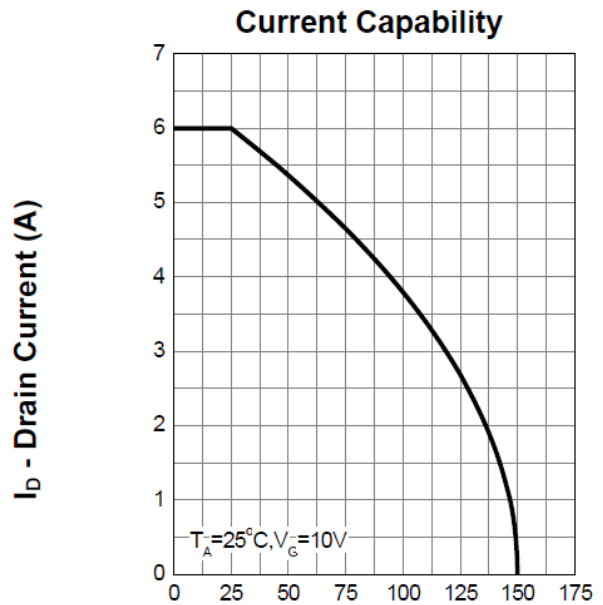
C: The current rating is based on the $t \leq 10s$ junction to ambient thermal resistance rating.

Typical Electrical and Thermal Characteristics

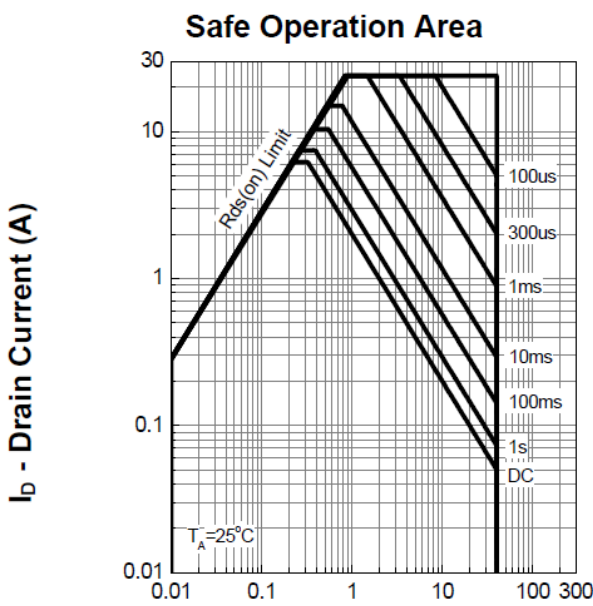
- N-Channel ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)



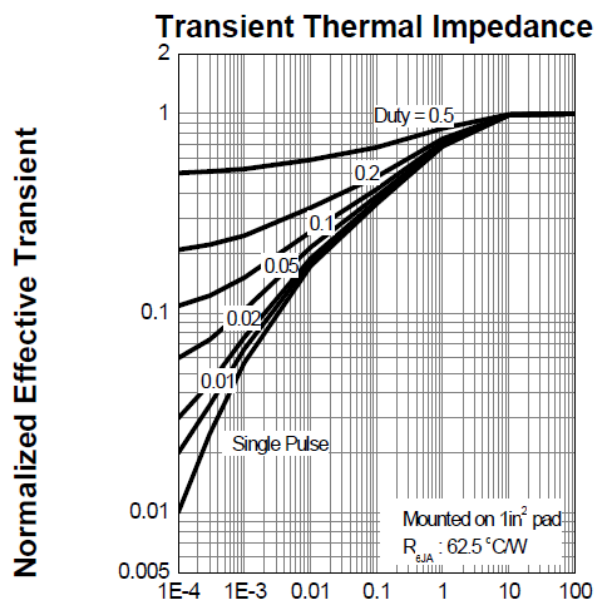
T_j - Junction Temperature ($^\circ\text{C}$)



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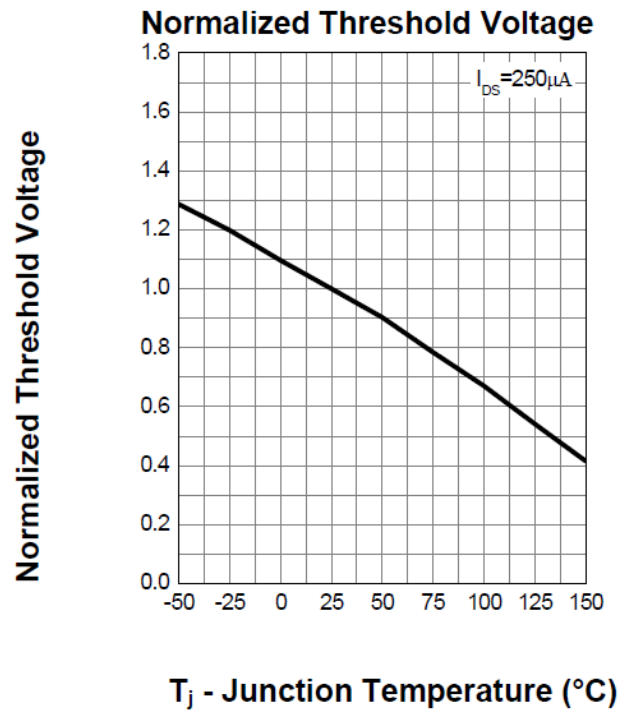
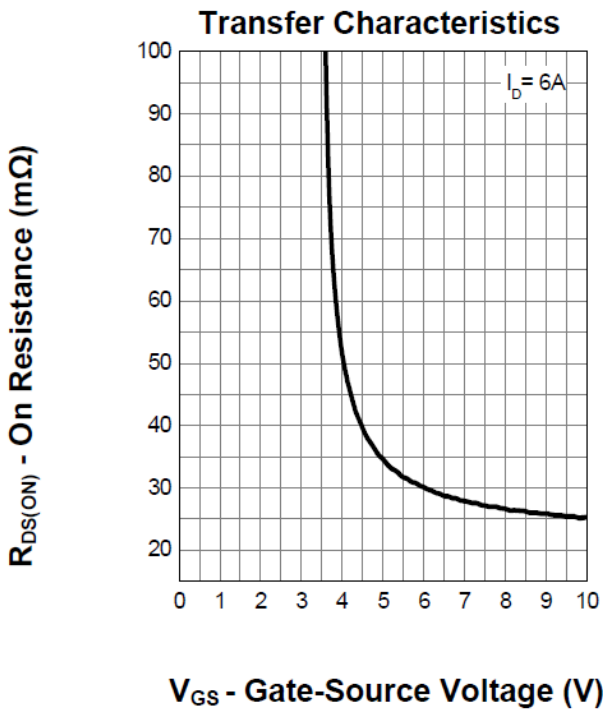
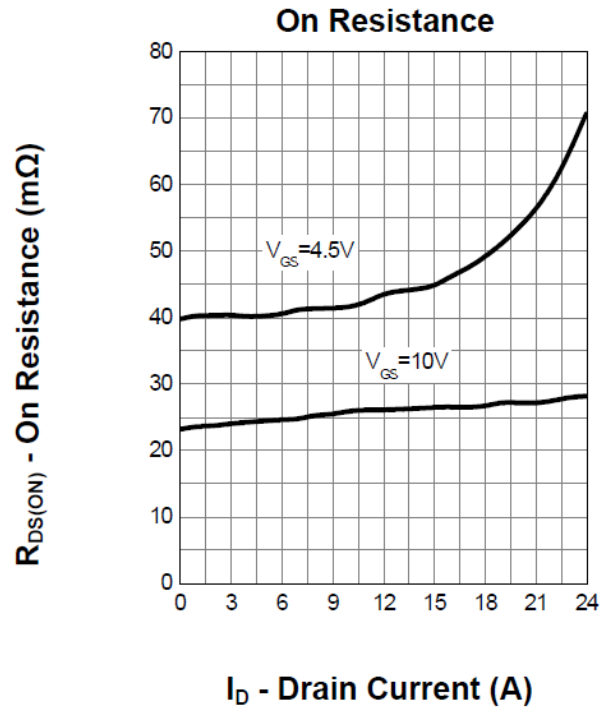
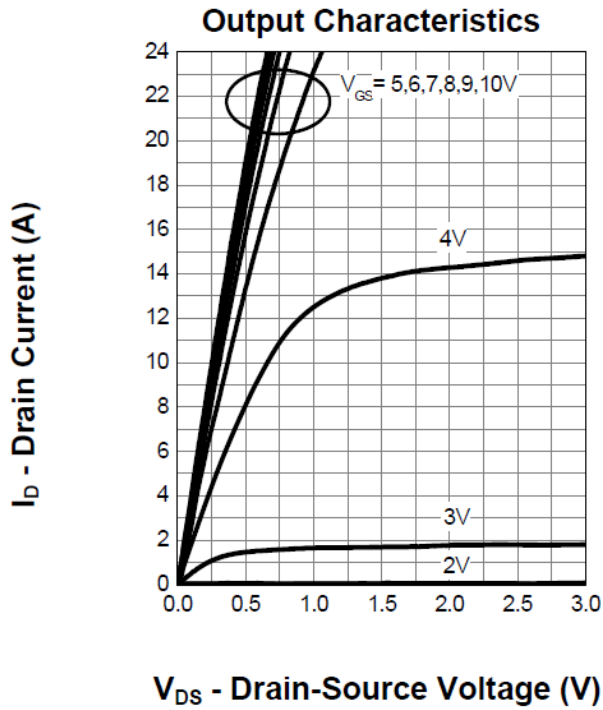


V_{DS} - Drain-Source Voltage (V)

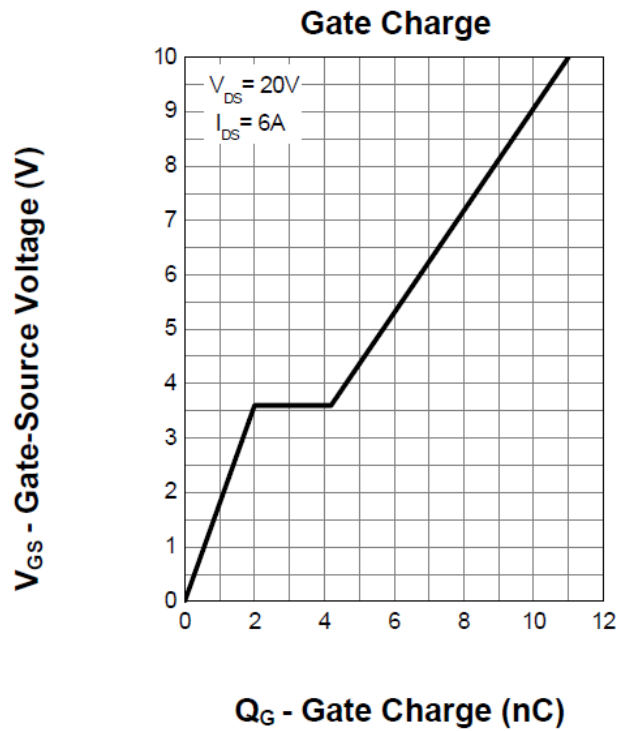
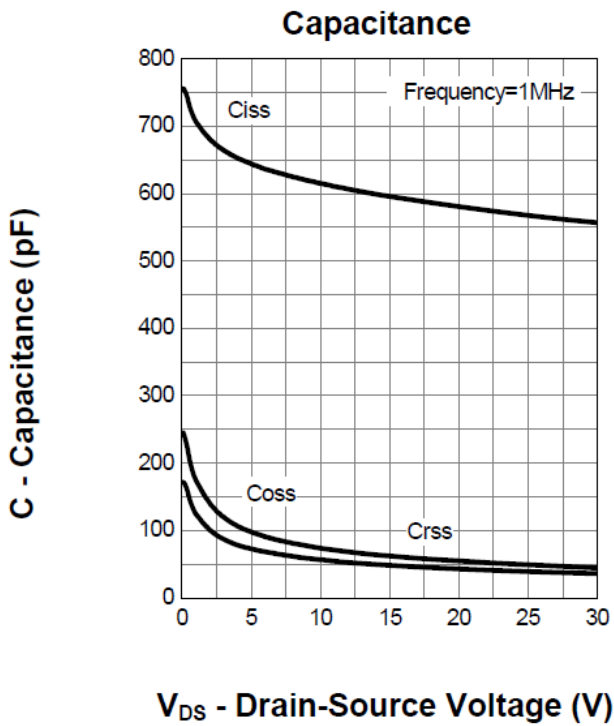
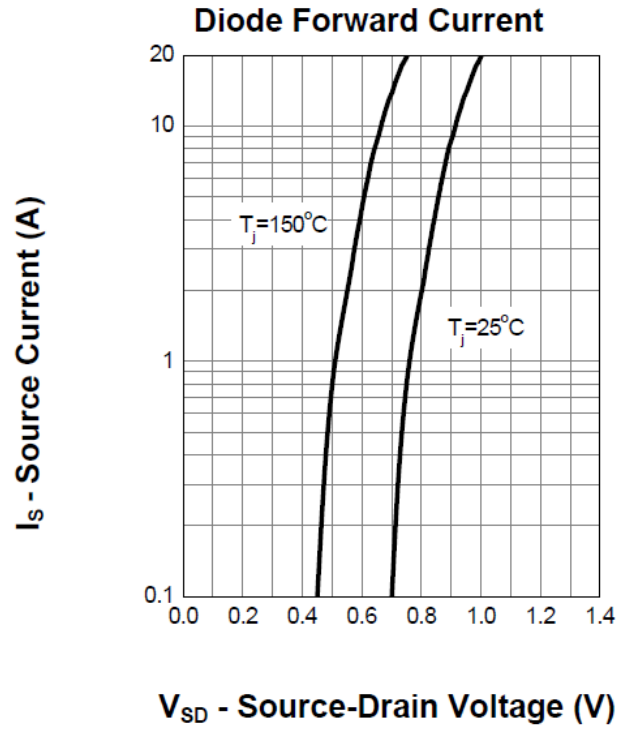
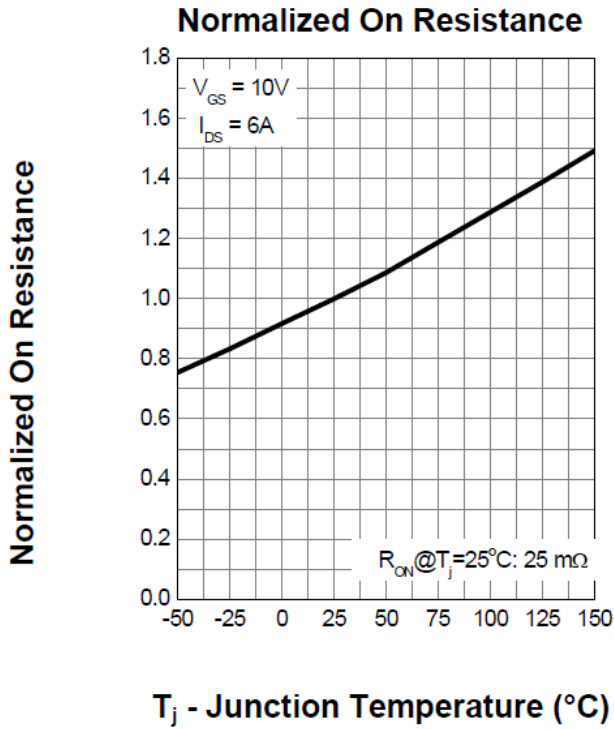


Square Wave Pulse Duration (sec)

Typical Electrical and Thermal Characteristics

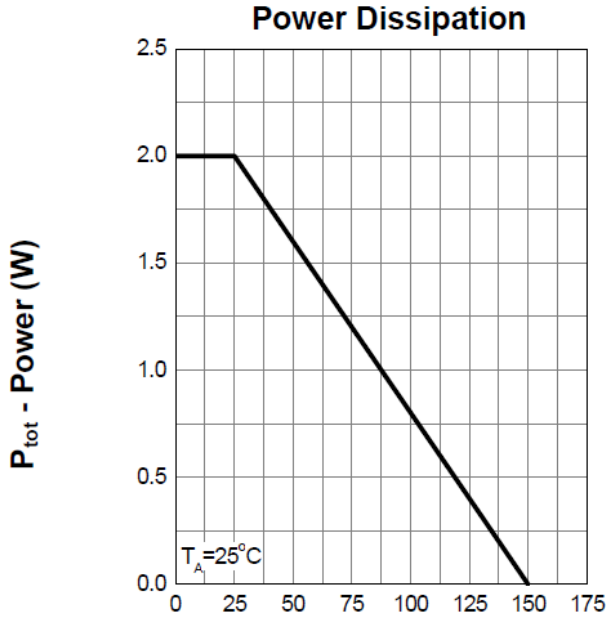


Typical Electrical and Thermal Characteristics

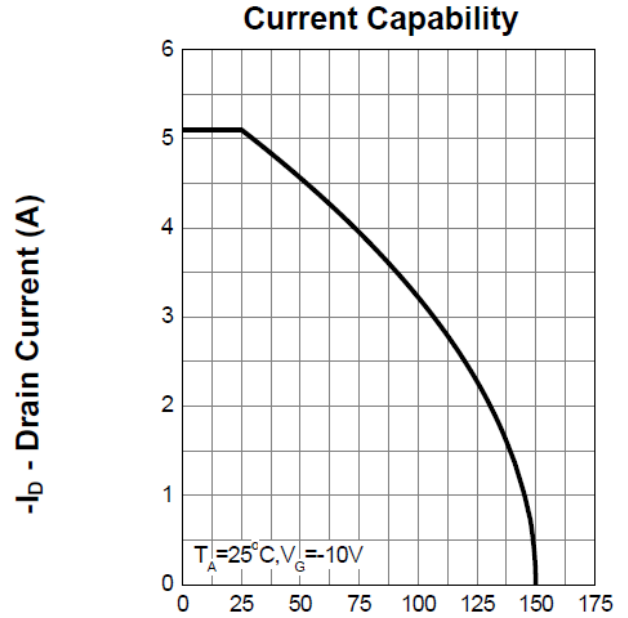


Typical Electrical and Thermal Characteristics

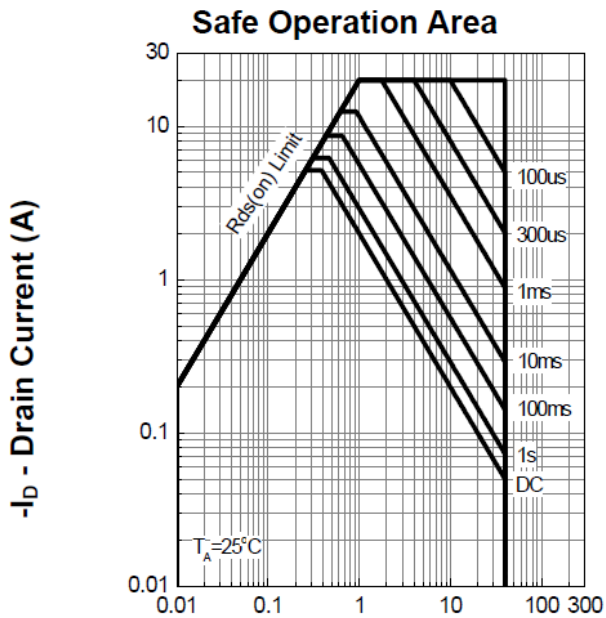
- P-Channel ($T_J = 25^\circ\text{C}$, unless otherwise noted)



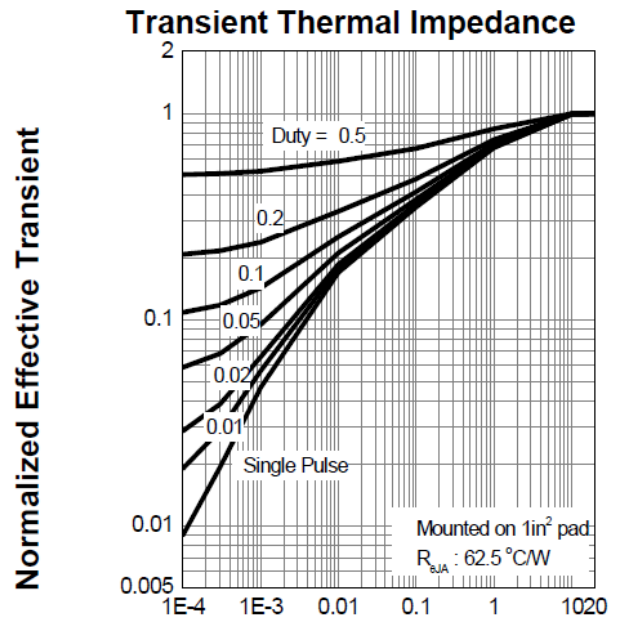
T_j - Junction Temperature ($^\circ\text{C}$)



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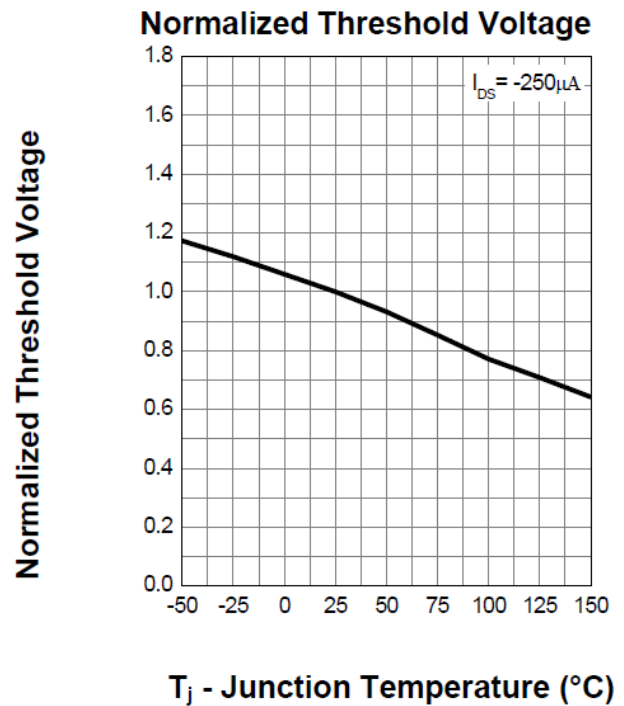
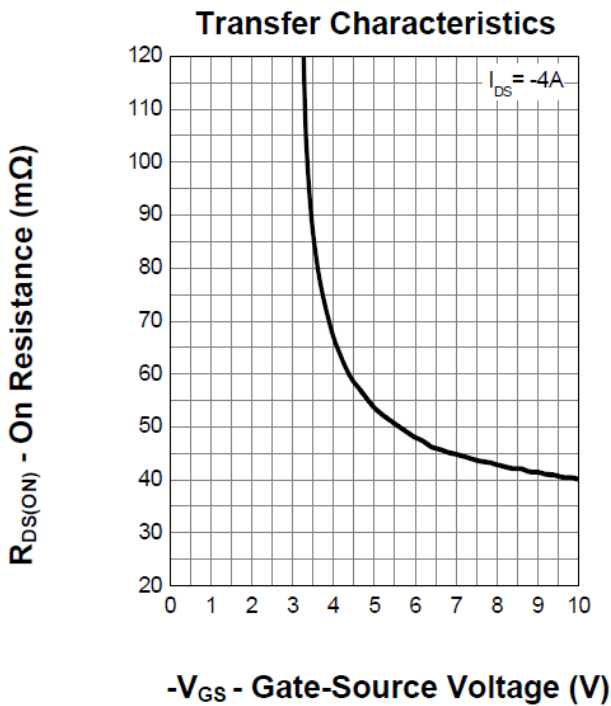
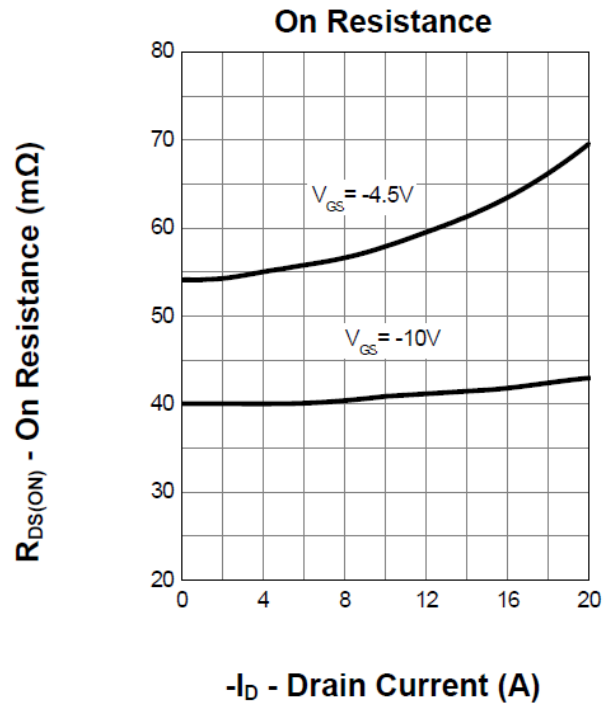
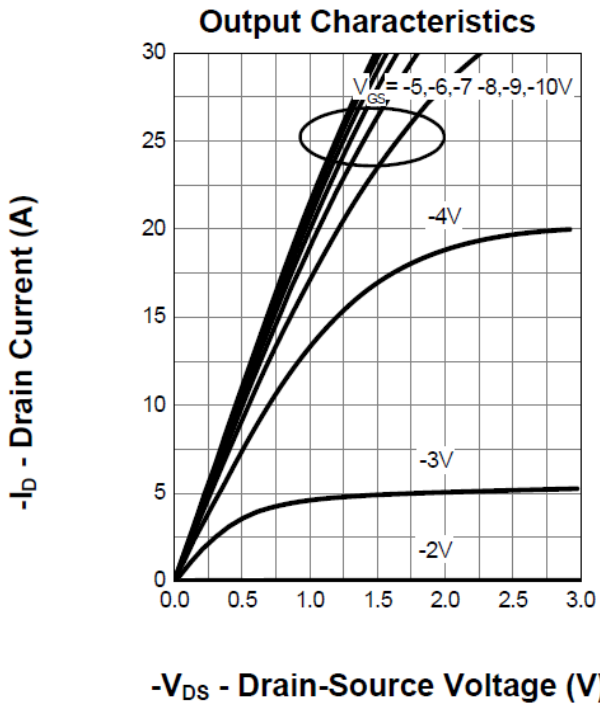


$-V_{DS}$ - Drain-Source Voltage (V)

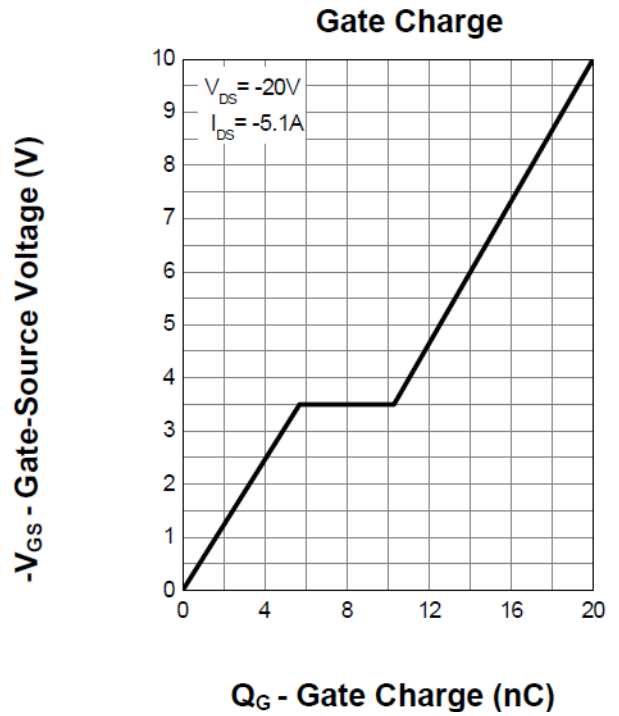
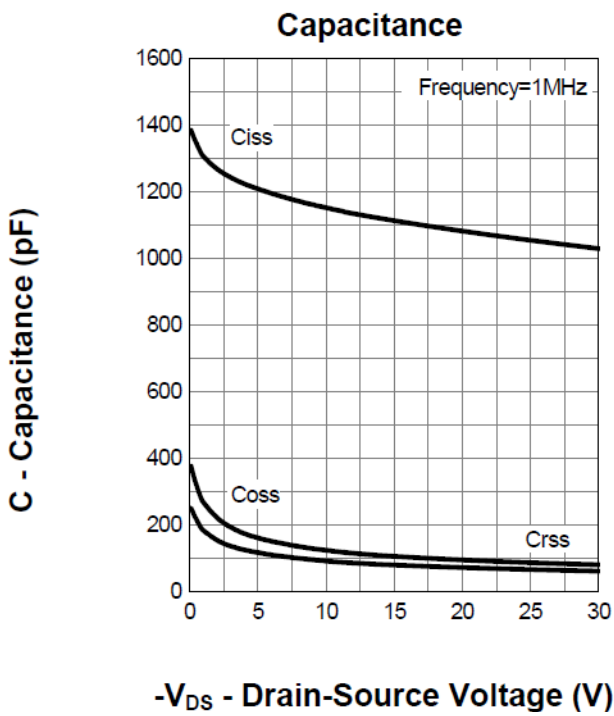
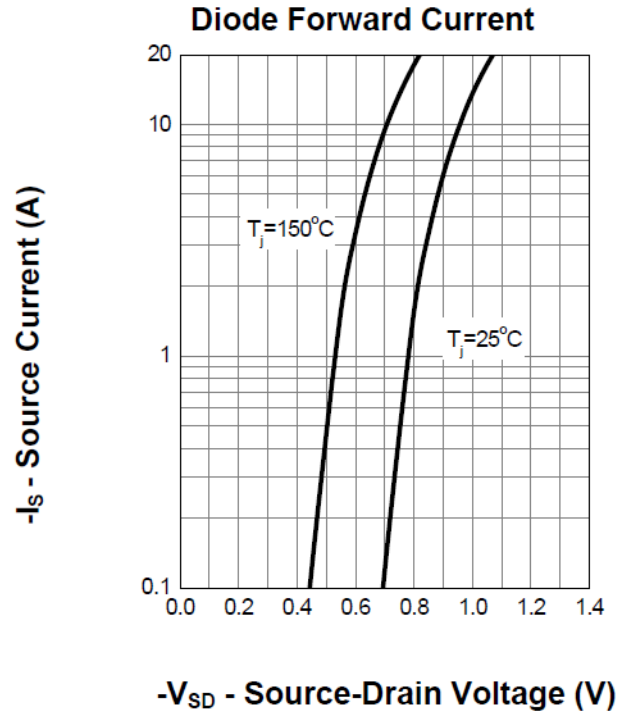
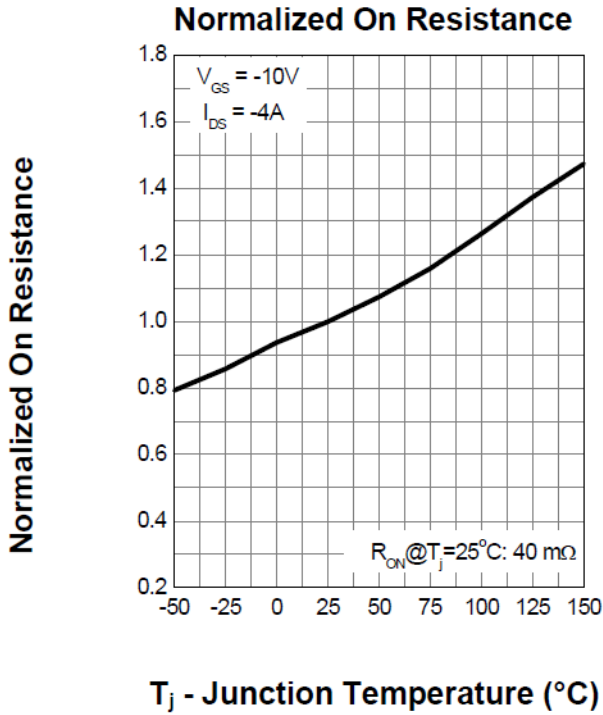


Square Wave Pulse Duration (sec)

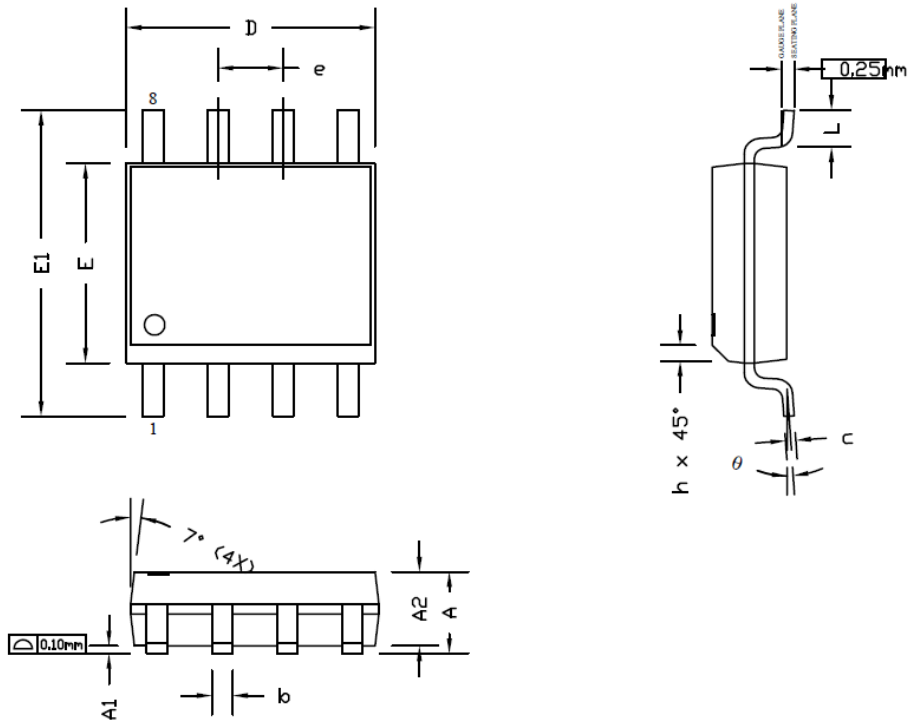
Typical Electrical and Thermal Characteristics



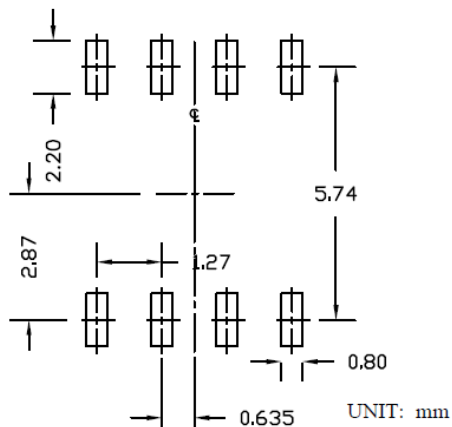
Typical Electrical and Thermal Characteristics



Package Information



RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.35	1.65	1.75	0.053	0.065	0.069
A1	0.10	0.15	0.25	0.004	0.006	0.010
A2	1.25	1.50	1.65	0.049	0.059	0.065
b	0.31	0.41	0.51	0.012	0.016	0.020
c	0.17	0.20	0.25	0.007	0.008	0.010
D	4.80	4.90	5.00	0.189	0.193	0.197
E	3.80	3.90	4.00	0.150	0.154	0.157
e	1.27 BSC			0.050 BSC		
E1	5.80	6.00	6.20	0.228	0.236	0.244
h	0.25	0.30	0.50	0.010	0.012	0.020
L	0.40	0.69	1.27	0.016	0.027	0.050
θ	0°	4°	8°	0°	4°	8°

NOTE

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONS ARE INCLUSIVE OF PLATING.
3. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
4. DIMENSION L IS MEASURED IN GAUGE PLANE.
5. CONTROLLING DIMENSION IS MILLIMETER.
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.